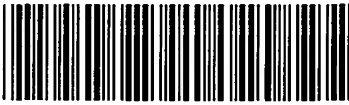


Search Notes

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10/716,257

Examiner

John Q. Nguyen

Applicant(s)/Patent under
Reexamination

AARON ET AL.

Art Unit

3654

SEARCHED

Class	Subclass	Date	Examiner
Previous search updated		12/7/06	W

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR